



## P3M171K0K3 SiC MOS N-Channel Enhancement Mode

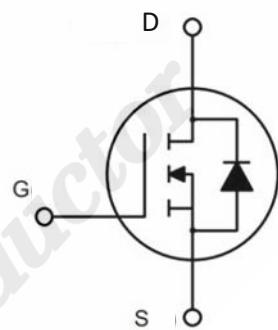
$V_{RRM}$	= 1700	V
$I_D$	= 6	A
$I_D (100^\circ C)$	= 4	A
$R_{DS(on)}$	= 1	$\Omega$

### SiC MOS P3M171K0K3 N-Channel Enhancement Mode



#### Features

- High Blocking Voltage with Low On-Resistance
- High-Frequency Operation
- Ultra-Small  $Q_{gd}$
- 100% UIS tested



#### Benefits

- Improve System Efficiency
- Increase Power Density
- Reduce Heat Sink Requirements
- Reduction of System Cost

#### Applications

- Solar Inverters
- EV Battery Chargers
- High Voltage DC/DC Converters
- Switch Mode Power Supplies

TO-247-3

Gate	1
Drain	2
Source	3



#### Order Information

Part Number	Package	Marking
P3M171K0K3	TO-247-3	P3M171K0K3



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## 1. Maximum Ratings

At  $T_J = 25^\circ\text{C}$ , unless specified otherwise

Parameter	Symbol	Value	Unit	Test Conditions
Drain - Source Voltage	$V_{DS\max}$	1700	V	$V_{GS} = 0\text{V}$ $I_D = 200\mu\text{A}$
Gate - Source Voltage (Dynamic)	$V_{GS\max}$	-8 / +19	V	AC ( $f > 1\text{Hz}$ )
Gate - Source Voltage (Static)	$V_{GSop}$	-3 / +15	V	Static
Continuous Drain Current	$I_D$	6	A	$V_{GS} = 15\text{V}$ $T_C = 25^\circ\text{C}$
		4		$V_{GS} = 15\text{V}$ $T_C = 100^\circ\text{C}$
Power Dissipation	$P_D$	68	W	
Operating Junction Temperature	$T_J$	-55 To +175	°C	
Storage Temperature	$T_{stg}$	-55 To +175	°C	
Solder Temperature	$T_L$	260	°C	
Mounting Torque	$M_d$	1 8.8	Nm lbf-in	M3 or 6-32 screw



## 2. Electrical Characteristics

At  $T_J = 25^\circ\text{C}$ , unless specified otherwise

Parameter	Symbol	Value			Unit	Test Conditions
		Min.	Typ.	Max.		
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	1700	/	/	V	$V_{GS} = 0\text{V}$ $I_D = 200\mu\text{A}$
Gate Threshold Voltage	$V_{GS(\text{th})}$	1.8	2.2	/	V	(tested after 30ms pulse at $V_{GS} = 15\text{V}$ ) $V_{DS} = V_{GS}$ $I_D = 2\text{mA}$ $T_J = 25^\circ\text{C}$
		/	1.45	/	V	$V_{DS} = V_{GS}$ $I_D = 2\text{mA}$ $T_J = 175^\circ\text{C}$
Zero Gate Voltage Drain Current	$I_{DSS}$	/	2.6	200	$\mu\text{A}$	$V_{GS} = 0\text{V}$ $V_{DS} = 1700\text{V}$
Gate-Source Leakage Current	$I_{GSS}$	/	2	125	nA	$V_{GS} = 15\text{V}$ $V_{DS} = 0\text{V}$
Drain-Source On-State Resistance	$R_{DS(\text{on})}$	/	1	1.4	$\Omega$	$V_{GS} = 15\text{V}$ $I_D = 2\text{A}$ $T_J = 25^\circ\text{C}$
		/	1.4	/		$V_{GS} = 15\text{V}$ $I_D = 2\text{A}$ $T_J = 125^\circ\text{C}$
		/	1.7	/		$V_{GS} = 15\text{V}$ $I_D = 2\text{A}$ $T_J = 175^\circ\text{C}$
Transconductance	$g_{fs}$	/	0.29	/	S	$V_{DS} = 20\text{V}$ $I_{DS} = 2\text{A}$ $T_J = 25^\circ\text{C}$
		/	0.31	/		$V_{DS} = 20\text{V}$ $I_{DS} = 2\text{A}$ $T_J = 175^\circ\text{C}$



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Parameter	Symbol	Value			Unit	Test Conditions	
		Min.	Typ.	Max.			
Input Capacitance	$C_{iss}$	/	235	/	pF	$V_{GS} = 0V$ $V_{DS} = 1000V$ $f = 1MHz$ $V_{AC} = 25mV$	
Output Capacitance	$C_{oss}$	/	8.9	/			
Reverse Transfer Capacitance	$C_{rss}$	/	2.8	/			
Coss Stored Energy	$E_{oss}$	/	9.4	/			
Turn-on Energy	$E_{on}$	/	95.7	/	$\mu J$	$V_{DS} = 1200V$ $V_{GS} = -3/15V$ $I_{DS} = 3A$ $R_G = 1\Omega$	
Turn-off Energy	$E_{off}$	/	16.9	/			
Turn-On Delay Time	$T_{d(on)}$	/	15.5	/	nS		
Rise Time	$T_r$	/	16.2	/			
Turn-Off Delay Time	$T_{d(off)}$	/	15.7	/			
Fall Time	$T_f$	/	31.2	/			
Internal Gate Resistance	$R_{G(int)}$	/	27	/	$\Omega$	$f = 1MHz$ $V_{AC} = 25mV$	
Gate to Source Charge	$Q_{gs}$	/	2.2	/	$nC$	$V_{DS} = 1200V$ $I_{DS} = 2A$ $V_{GS} = -3 \text{ to } 15V$ $I_G = 2mA$	
Gate to Drain Charge	$Q_{gd}$	/	2.5	/			
Total Gate Charge	$Q_g$	/	7.4	/			



### 3. Reverse Diode Characteristics

At  $T_J=25\text{ }^\circ\text{C}$ , unless specified otherwise

Parameter	Symbol	Value		Unit	Test Conditions
		Typ.	Max.		
Diode Forward Voltage	$V_{SD}$	5.1	/	V	$V_{GS} = -3\text{V}$ $I_{SD} = 1\text{A}$ $T_J = 25\text{ }^\circ\text{C}$
		5.1	/	V	$V_{GS} = -3\text{V}$ $I_{SD} = 1\text{A}$ $T_J = 175\text{ }^\circ\text{C}$
Continuous Diode Forward Current	$I_S$	5	/	A	$V_{GS} = -3\text{V}$
Reverse Recover Time	$t_{rr}$	35.4	/	ns	$V_{GS} = -3/15\text{V}$ $I_{SD} = 3\text{A}$ $V_R = 1200\text{V}$ $d_i/d_t = 650\text{A}/\mu\text{s}$ $T_J = 25\text{ }^\circ\text{C}$
Reverse Recovery Charge	$Q_{rr}$	69.1	/	nC	
Peak Reverse Recovery Current	$I_{rrm}$	4.2	/	A	

### 4. Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance from Junction to Case	$R_{\theta JC}$	2.2	$^\circ\text{C}/\text{W}$



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## 5. Typical Performance

At  $T_J = 25^\circ\text{C}$ , unless specified otherwise

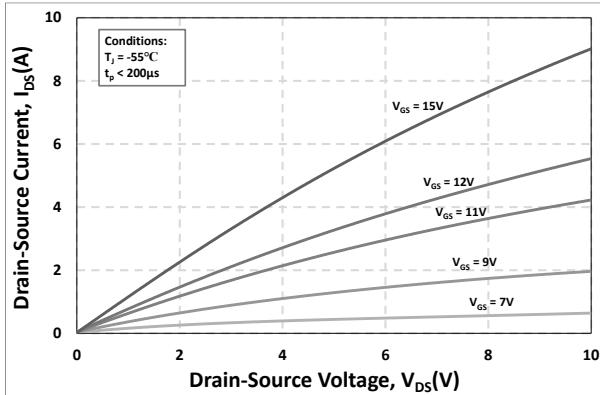


Figure 1. Output Characteristics  $T_J = -55^\circ\text{C}$

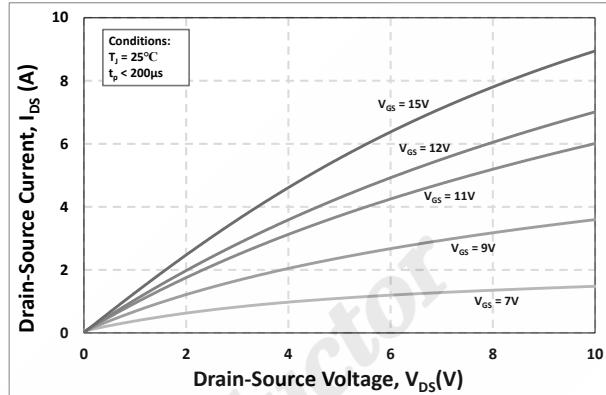


Figure 2. Output Characteristics  $T_J = 25^\circ\text{C}$

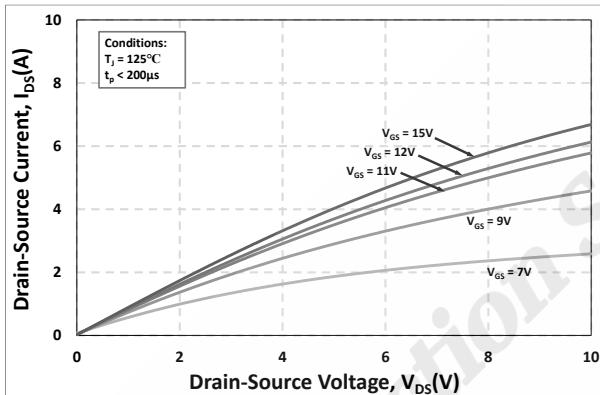


Figure 3. Output Characteristics  $T_J = 125^\circ\text{C}$

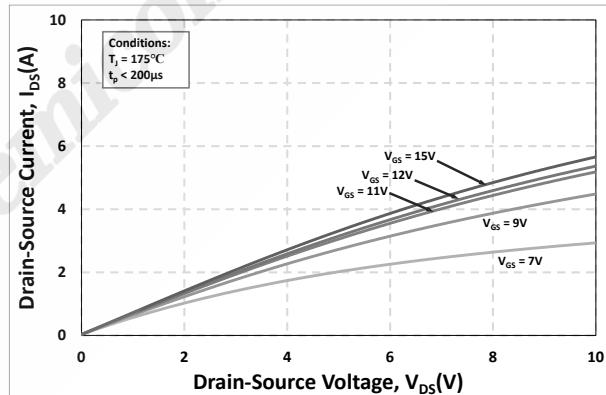


Figure 4. Output Characteristics  $T_J = 175^\circ\text{C}$

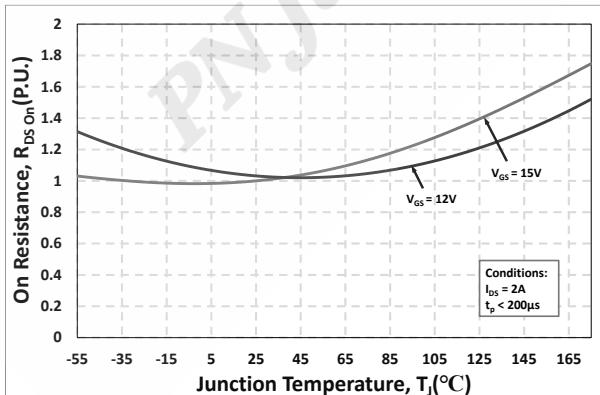


Figure 5. Normalized On-Resistance vs. Temperature

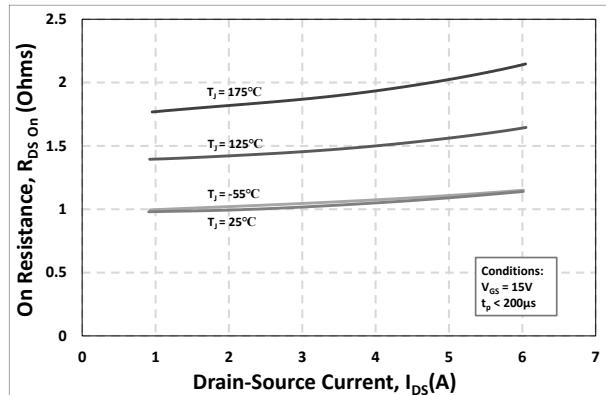


Figure 6. On-Resistance vs. Drain Current Various Temperatures



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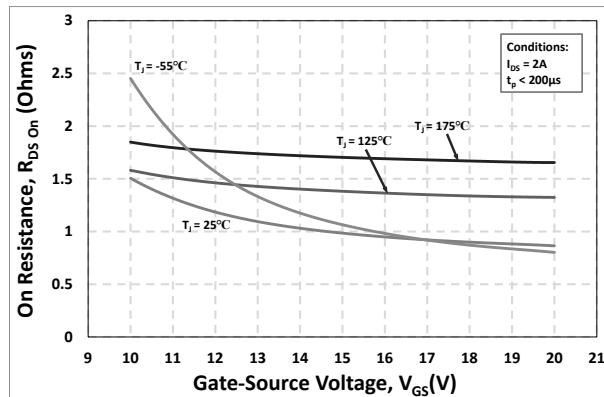


Figure 7. On-Resistance vs. Gate-Source Voltage

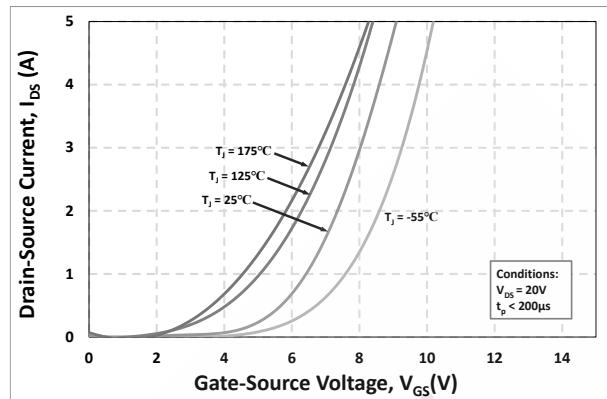


Figure 8. Transfer Characteristic for Various Junction Temperatures

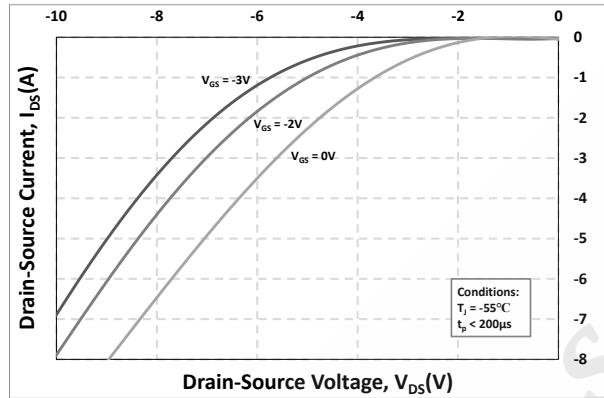


Figure 9. Body Diode Characteristic at  $-55^\circ\text{C}$

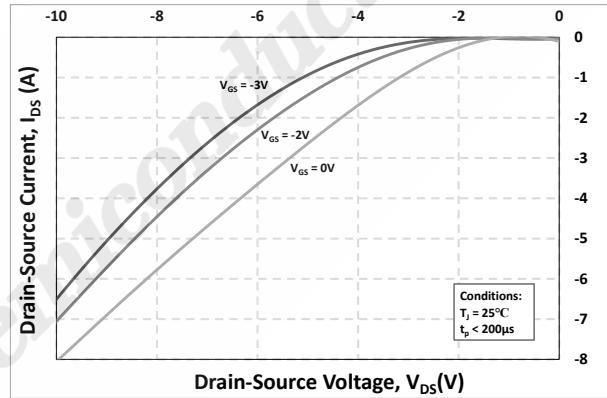


Figure 10. Body Diode Characteristic at  $25^\circ\text{C}$

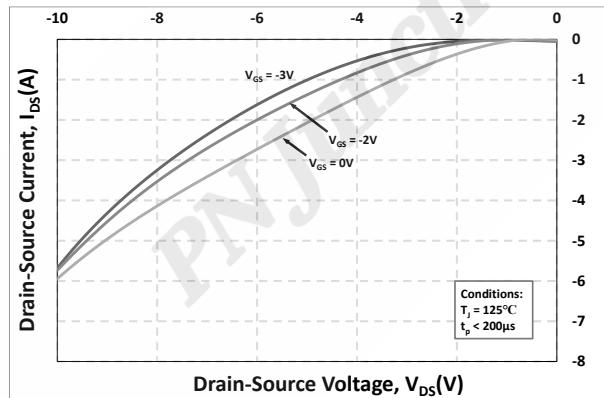


Figure 11. Body Diode Characteristic at  $125^\circ\text{C}$

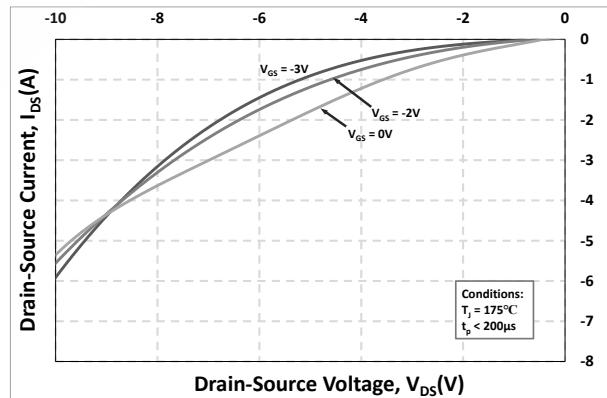


Figure 12. Body Diode Characteristic at  $175^\circ\text{C}$



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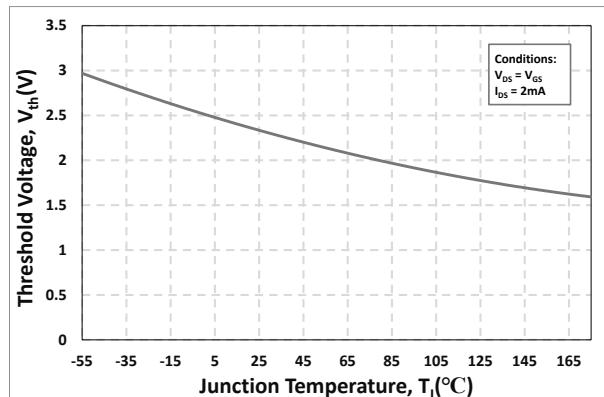


Figure 13. Threshold Voltage vs. Temperatures

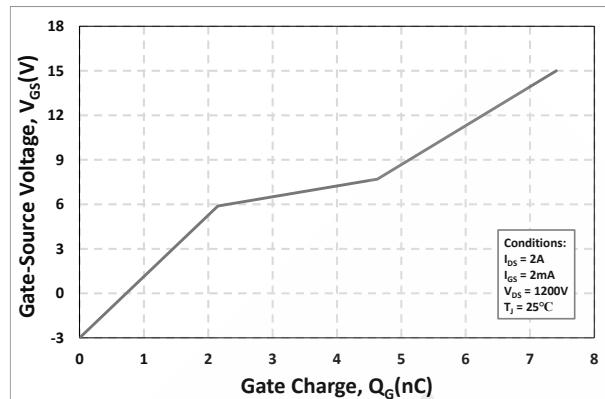


Figure 14. Gate Charge Characteristics

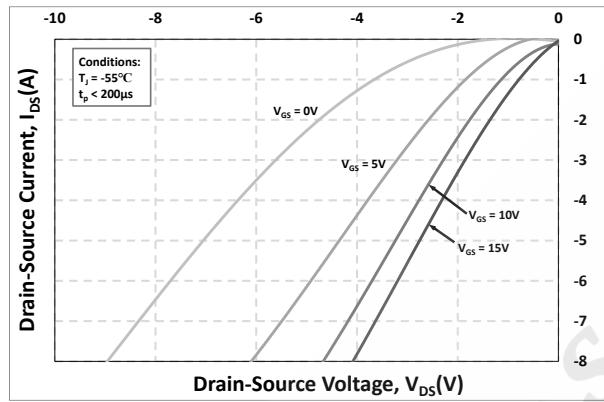


Figure 15. 3rd Quadrant Characteristic at  $-55^\circ\text{C}$

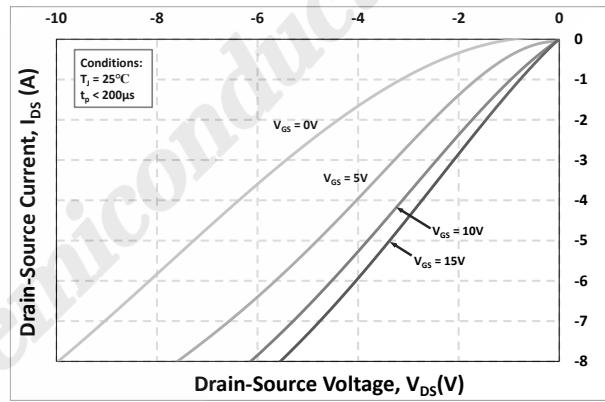


Figure 16. 3rd Quadrant Characteristic at  $25^\circ\text{C}$

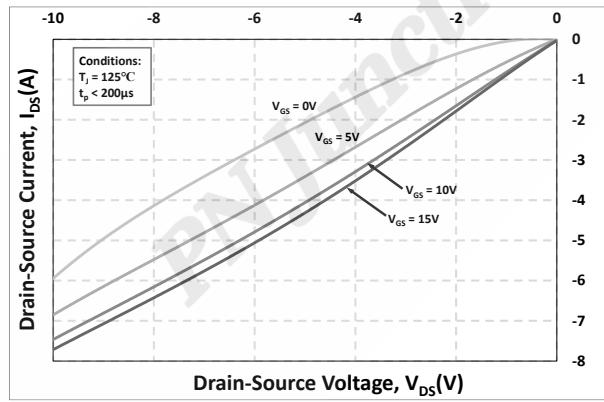


Figure 17. 3rd Quadrant Characteristic at  $125^\circ\text{C}$

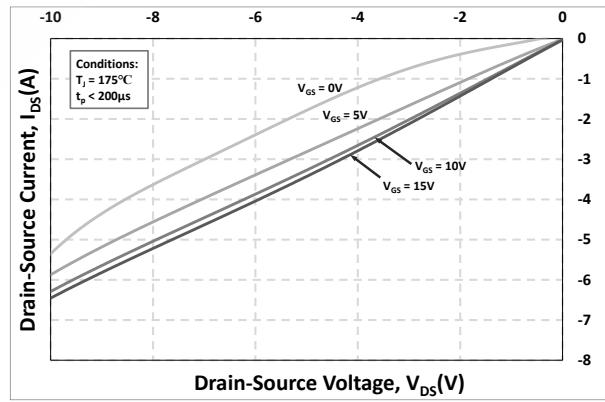


Figure 18. 3rd Quadrant Characteristic at  $175^\circ\text{C}$



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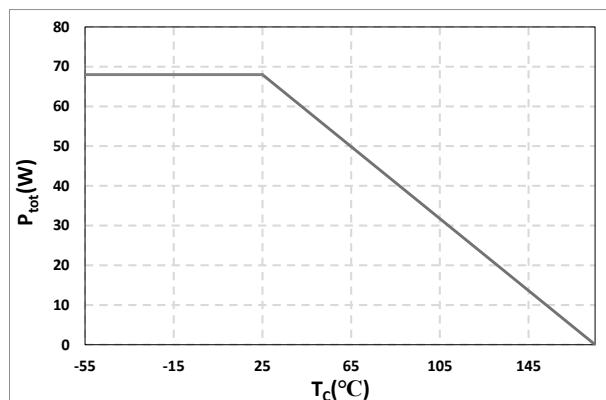


Figure 19. Maximum Power Dissipation Derating vs. Case Temperature

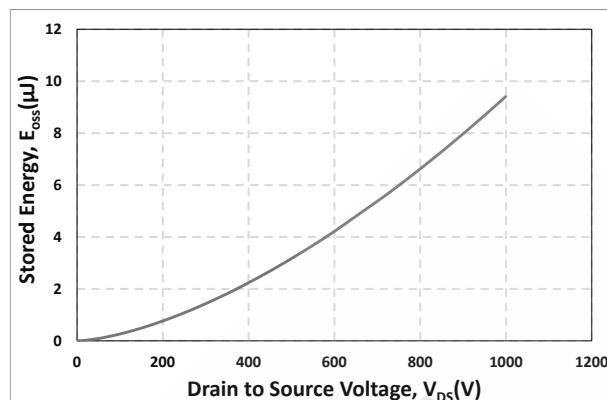


Figure 20. Output Capacitor Stored Energy

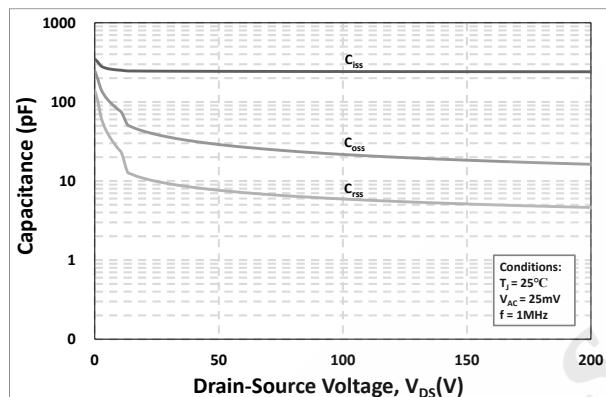


Figure 21. Capacitances vs. Drain-Source Voltage (0-200V)

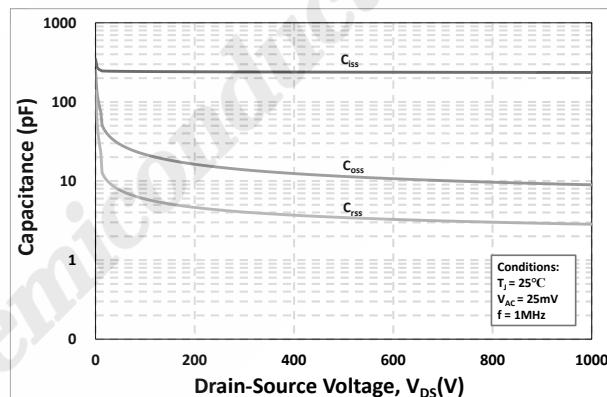


Figure 22. Capacitances vs. Drain-Source Voltage (0-1000V)

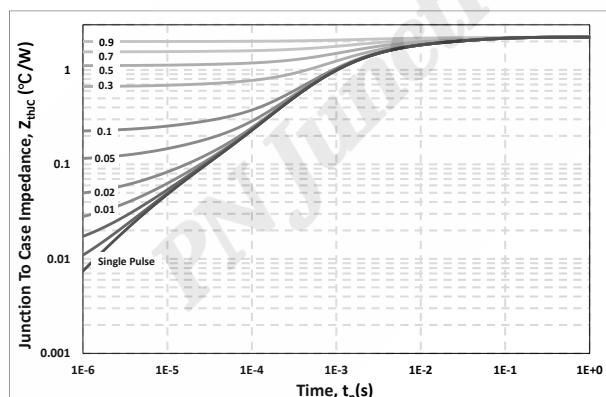


Figure 23. Transient Thermal Impedance (Junction - Case)

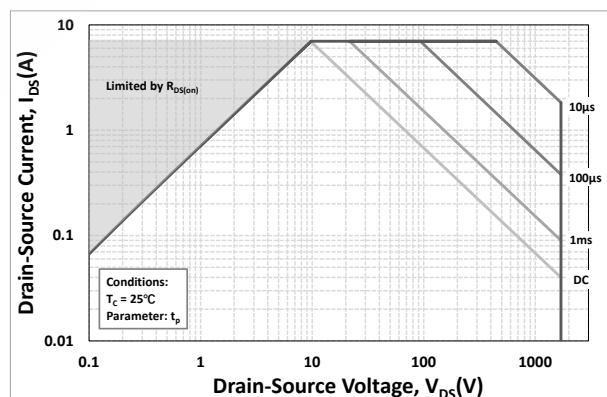


Figure 24. Safe Operating Area



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## 6. Definitions

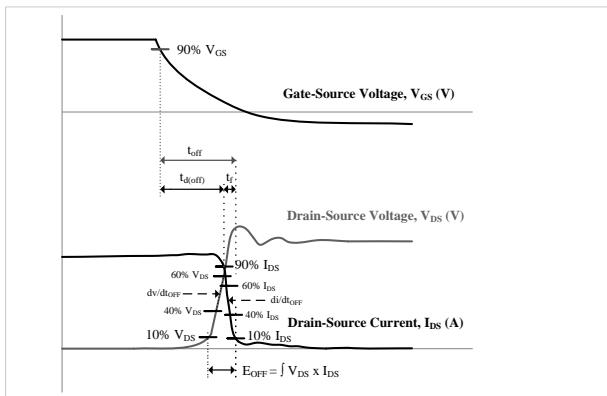


Figure 25. Turn-off Transient Definitions

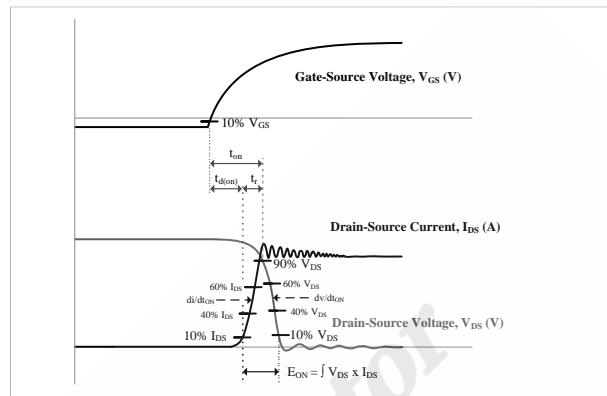


Figure 26. Turn-on Transient Definitions

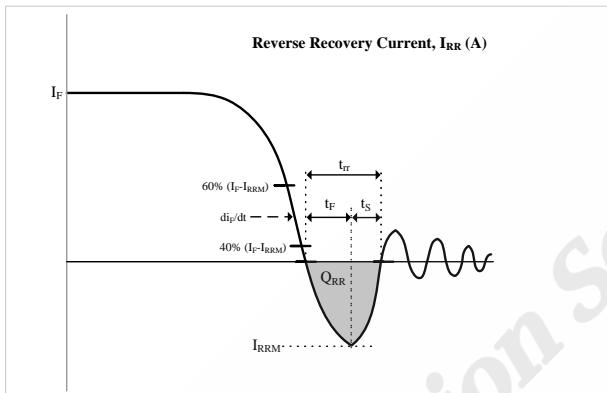


Figure 27. Reverse Recovery Definitions

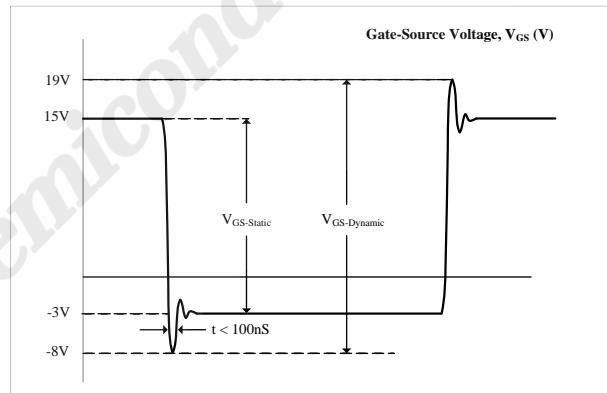
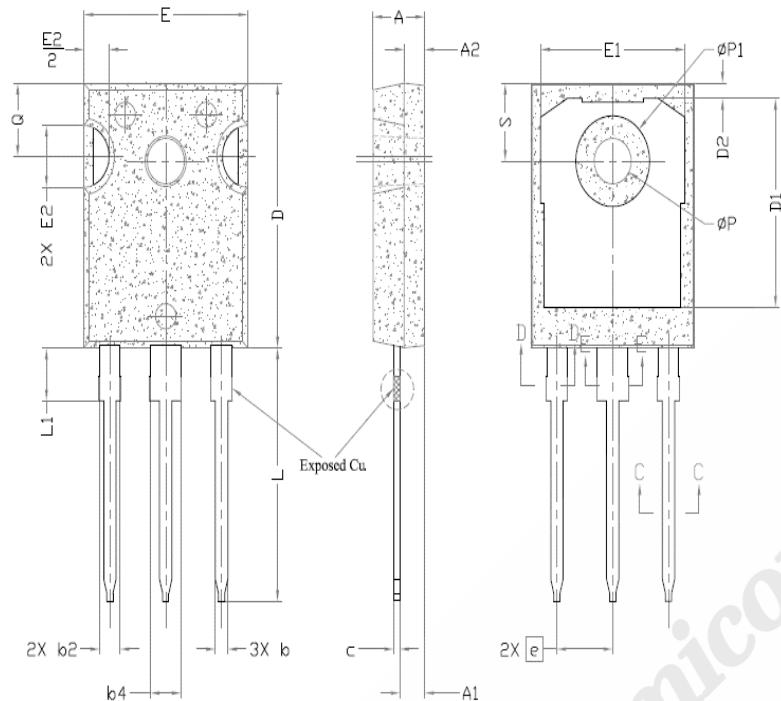


Figure 28.  $V_{GS}$  Transient Definitions



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## 7. Package Outlines



SYMBOL	DIMENSIONS			NOTES
	MIN.	NOM.	MAX.	
A	4,83	5,02	5,21	
A1	2,29	2,41	2,55	
A2	1,50	2,00	2,49	
b	1,12	1,20	1,33	
b1	1,12	1,20	1,28	
b2	1,91	2,00	2,39	6
b3	1,91	2,00	2,34	
b4	2,87	3,00	3,22	6, 8
b5	2,87	3,00	3,18	
c	0,55	0,60	0,69	6
c1	0,55	0,60	0,65	
D	20,80	20,95	21,10	4
D1	16,25	16,55	17,65	5
D2	0,51	1,19	1,35	
E	15,75	15,94	16,13	4
E1	13,46	14,02	14,16	5
E2	4,32	4,91	5,49	3
e	5,44BSC			
L	19,81	20,07	20,32	
L1	4,10	4,19	4,40	6
ØP	3,56	3,61	3,65	7
ØP1	7,19REF.			
Q	5,39	5,79	6,20	
S	6,04	6,17	6,30	

Drawing and Dimensions



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